

# 54121/DM54121/DM74121 One-Shot with Clear and Complementary Outputs

### **General Description**

The DM54/74121 is a monostable multivibrator featuring both positive and negative edge triggering with complementary outputs. An internal  $2k\Omega$  timing resistor is provided for design convenience minimizing component count and layout problems. This device can be used with a single external capacitor. Inputs (A) are active-low trigger transition inputs and input (B) is an active-high transition Schmitt-trigger input that allows jitter-free triggering from inputs with transition rates as slow as 1 volt/second. A high immunity to  $V_{CC}$  noise of typically 1.5V is also provided by internal circuitry at the input stage.

To obtain optimum and trouble free operation please read operating rules and NSC one-shot application notes carefully and observe recommendations.

#### **Features**

- Triggered from active-high transition or active-low transition inputs
- Variable pulse width from 30 ns to 28 seconds

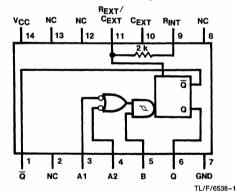
- Jitter free Schmitt-trigger input
- Excellent noise immunity typically 1.2V
- Stable pulse width up to 90% duty cycle
- TTL, DTL compatible
- Compensated for V<sub>CC</sub> and temperature variations
- Input clamp diodes
- Alternate Military/Aerospace device (54121) is available. Contact a National Semiconductor Sales Office/ Distributor for specifications.

## **Functional Description**

The basic output pulse width is determined by selection of an internal resistor  $R_{INT}$  or an external resistor  $(R_X)$  and capacitor  $(C_X)$ . Once triggered the output pulse width is independent of further transitions of the inputs and is a function of the timing components. Pulse width can vary from a few nano-seconds to 28 seconds by choosing appropriate  $R_X$  and  $C_X$  combinations. There are three trigger inputs from the device, two negative edge-triggering (A) inputs, one positive edge Schmitt-triggering (B) input.

# **Connection Diagram**

#### **Dual-In-Line Package**



Order Number 54121DMQB, 54121FMQB, DM54121J, DM54121W or DM74121N See NS Package Number J14A, N14A or W14B

#### **Function Table**

Inputs			Outputs		
A1	A2	В	Q	Q	
L	Х	Н	L	Ξ	
X	L	Н	L	Н	
Х	Х	L	L	н	
Н	н	Х	L	Н	
Н	↓	Н		T	
↓	н	н	7.	7.	
↓ ↓	↓	Н	J.	T	
L	Х	1	7.	ਪ	
X	L	<u> </u>		L T	

H = High Logic Level

L = Low Logic Level

X = Can Be Either Low or High

Positive Going Transition

↓ = Negative Going Transition

□ = A Negative Pulse

#### **Absolute Maximum Ratings (Note)**

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage 7V Input Voltage 5.5V

Operating Free Air Temperature Range

Storage Temperature Range  $-65^{\circ}\text{C}$  to  $+150^{\circ}\text{C}$ 

Note: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the "Electrical Characteristics" table are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

# **Recommended Operating Conditions**

Symbol	Parameter	DM54121			DM74121			Units	
	Farameter		Min	Nom	Max	Min	Nom	Max	Units
Vcc	Supply Voltage		4.5	5	5.5	4.75	5	5.25	٧
V <sub>T+</sub>	Positive-Going Input Threshold Voltage at the A Input (V <sub>CC</sub> = Min)			1.4	2		1.4	2	٧
V <sub>T</sub> _	Negative-Going Input Threshold Voltage at the A Input (V <sub>CC</sub> = Min)		0.8	1.4		0.8	1.4	}	V
V <sub>T+</sub>	Positive-Going Input Threshold Voltage at the B Input (V <sub>CC</sub> = Min)			1.5	2		1.5	2	٧
V <sub>T</sub> -	Negative-Going Input Threshold Voltage at the B Input (V <sub>CC</sub> = Min)		0.8	1.3		0.8	1.3		V
Гон	High Level Output Current				-0.4			-0.4	mA
loL	Low Level Output Current				16			16	mA
t <sub>W</sub>	Input Pulse Width (Note 1)		40			40			ns
dV/dt	Rate of Rise or Fall of Schmidt Input (B) (Note 1)				1			1	V/s
dV/dt	Rate of Rise or Fall of Logic Input (A) (Note 1)				1			1	V/μs
R <sub>EXT</sub>	External Timing Resistor (Note 1)		1.4		30	1.4		40	kΩ
C <sub>EXT</sub>	External Timing Capacitance (Note 1)		0		1000	0		1000	μF
DC	Duty Cycle (Note 1)	$R_T = 2 k\Omega$			67			67	%
		$R_T = R_{EXT}$ (Max)			90			90	
T <sub>A</sub>	Free Air Operating Tem	perature	-55		125	0		70	°C

Note 1:  $T_A = 25^{\circ}C$  and  $V_{CC} = 5V$ .

# Electrical Characteristics over recommended operating free air temperature range (unless otherwise noted)

Symbol	Parameter	Conditions		Min	Typ (Note 1)	Max	Units
VI	Input Clamp Voltage	$V_{CC} = Min, I_I = -12 mA$				-1.5	>
V <sub>OH</sub>	High Level Output Voltage	$V_{CC} = Min, I_{OH} = Max,$ $V_{IL} = Max, V_{IH} = Min$		2.4	3.4		٧
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC} = Min, I_{OL} = Max,$ $V_{IH} = Min, V_{IL} = Max$			0.2	0.4	٧
l <sub>l</sub>	Input Current @ Max Input Voltage	$V_{CC} = Max, V_I = 5.5V$				1	mA
I <sub>IH</sub> High Level Input Current		V <sub>CC</sub> = Max	A1, A2			40	μА
	$V_1 = 2.4V$	В			80	] "	
I <sub>IL</sub> Low Level Input Current	Low Level Input	$V_{CC} = Max$ $V_1 = 0.4V$	A1, A2			-1.6	mA
	Current		В			-3.2	
Short Circuit Output Current	V <sub>CC</sub> = Max	DM54	-20		-55	mA	
	Output Current	(Note 2)	DM74	-18		-55	] ""
ICC Supply Current	Supply Current	Supply Current V <sub>CC</sub> = Max			13	25	mA
			Triggered		23	40	] ""

Note 1: All typicals are at  $V_{CC} = 5V$ ,  $T_A = 25$ °C.

Note 2: Not more than one output should be shorted at a time.

# Switching Characteristics at V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C (See Section 1 for Test Waveforms and Outout Load)

Symbol	Parameter	From (Input) To (Output)	Conditions	Min	Max	Units
t <sub>PLH</sub>	Propagation Delay Time Low to High Level Output	A1, A2 to Q	C <sub>EXT</sub> = 80 pF R <sub>INT</sub> to V <sub>CC</sub>		70	ns
t <sub>PLH</sub>	Propagation Delay Time Low to High Level Output	B to Q	$C_L = 15  pF$ $R_L = 400 \Omega$		55	ns
t <sub>PHL</sub>	Propagation Delay Time High to Low Level Output	A1, A2 to Q			80	ns
t <sub>PHL</sub>	Propagation Delay Time High to Low Level Output	B to Q			65	ns
t <sub>W(OUT)</sub>	Output Pulse Width Using the Internal Timing Resistor	A1, A2 or B to Q, Q	$C_{EXT} = 80 \text{ pF}$ $R_{INT} \text{ to } V_{CC}$ $R_L = 400\Omega$ $C_L = 15 \text{ pF}$	70	150	ns
t <sub>W(OUT)</sub>	Output Pulse Width Using Zero Timing Capacitance	A1, A2 to Q, Q	$C_{EXT} = 0 \text{ pF}$ $R_{INT} \text{ to } V_{CC}$ $R_L = 400\Omega$ $C_L = 15 \text{ pF}$		50	ns
<sup>t</sup> w(OUT)	Output Pulse Width Using External Timing Resistor	A1, A2 to Q, Q	$\begin{aligned} C_{\text{EXT}} &= 100 \text{ pF} \\ R_{\text{INT}} &= 10 \text{ k}\Omega \\ R_{\text{L}} &= 400\Omega \\ C_{\text{L}} &= 15 \text{ pF} \end{aligned}$	600	800	ns
		A1, A2 to Q, Q	$C_{EXT} = 1 \mu F$ $R_{INT} = 10 k\Omega$ $R_{L} = 400\Omega$ $C_{L} = 15 pF$	6	8	ms

# **Operating Rules**

- 1. To use the internal 2 k $\Omega$  timing resistor, connect the R $_{INT}$  pin to V $_{CC}.$
- 2. An external resistor  $(R_X)$  or the internal resistor  $(2 \text{ k}\Omega)$  and an external capacitor  $(C_X)$  are required for proper operation. The value of  $C_X$  may vary from 0 to any necessary value. For small time constants use high-quality mica, glass, polypropylene, polycarbonate, or polystyrene capacitors. For large time constants use solid tantalum or special aluminum capacitors. If the timing capacitors have leakages approaching 100 nA or if stray capacitance from either terminal to ground is greater than 50 pF the timing equations may not represent the pulse width the device generates.
- 3. The pulse width is essentially determined by external timing components  $R_X$  and  $C_X$ . For  $C_X < 1000$  pF see Figure 1 design curves on  $T_W$  as function of timing components value. For  $C_X > 1000$  pF the output is defined as:

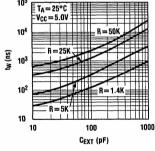
$$t_W = K R_X C_X$$

where [Rx is in Kilo-ohm]

[C<sub>X</sub> is in pico Farad]

[T<sub>W</sub> is in nano second]

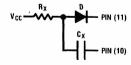
 $[K \approx 0.7]$ 



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#### FIGURE 1

 If C<sub>X</sub> is an electrolytic capacitor a switching diode is often required for standard TTL one-shots to prevent high inverse leakage current (Figure 2).

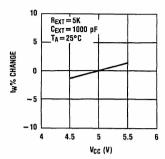


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FIGURE 2

#### **Operating Rules** (Continued)

 Output pulse width versus V<sub>CC</sub> and operation temperatures: Figure 3 depicts the relationship between pulse width variation versus V<sub>CC</sub>. Figure 4 depicts pulse width variation versus ambient temperature.



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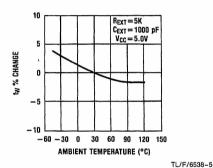
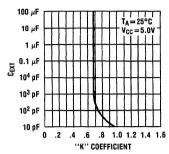


FIGURE 3

FIGURE 4

 The "K" coefficient is not a constant, but varies as a function of the timing capacitor C<sub>X</sub>. Figure 5 details this characteristic.



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7. Under any operating condition  $C_X$  and  $R_X$  must be kept as close to the one-shot device pins as possible to minimize stray capacitance, to reduce noise pick-up, and to reduce  $I \times R$  and Ldi/dt voltage developed along their connecting paths. If the lead length from  $C_X$  to pins (10) and (11) is greater than 3 cm, for example, the output pulse width might be quite different from values predicted from the appropriate equations. A non-inductive and low capacitive path is necessary to ensure complete discharge of  $C_X$  in each cycle of its operation so that the

FIGURE 5

8. V<sub>CC</sub> and ground wiring should conform to good high-frequency standards and practices so that switching transients on the V<sub>CC</sub> and ground return leads do not cause interaction between one-shots. A 0.01 μF to 0.10 μF bypass capacitor (disk ceramic or monolithic type) from V<sub>CC</sub> to ground is necessary on each device. Furthermore, the bypass capacitor should be located as close to the V<sub>CC</sub>-pin as space permits.

output pulse width will be accurate.

For further detailed device characteristics and output performance please refer to the NSC one-shot application note, AN-366.